



QNHCHIP

QNM3N50NA

# Product Specification

QNM3N50NA

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500V N-Channel MOSFET



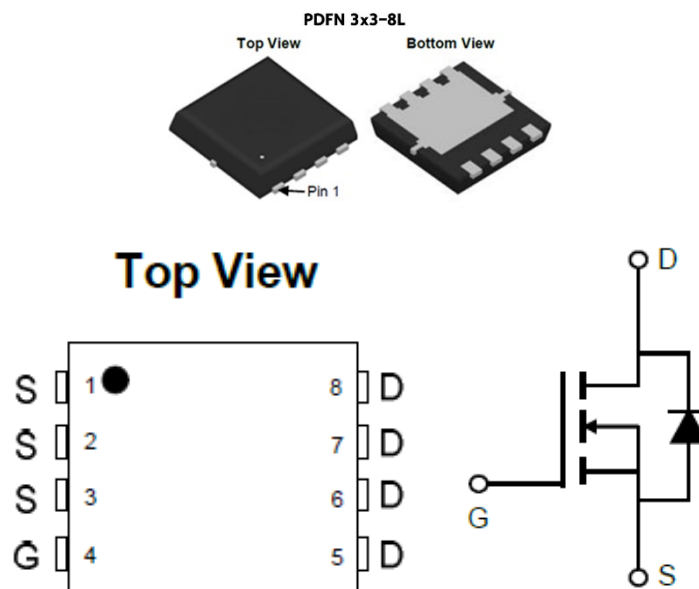
## FEATURES

- 500V,3A  
 $R_{DS(ON)} < 3.5\Omega @ V_{GS} = 10V$
- Fast Switching
- Lead free product is acquired
- Excellent  $R_{DS(ON)}$  and Low Gate Charge

## Applications

- PWM applications
- Load Switch
- Power management

## Pin Description



NO.	Symbol	Description
1	S	SOURCE
2	S	SOURCE
3	S	SOURCE
4	G	GATE
5	D	DRAIN
6	D	DRAIN
7	D	DRAIN
8	D	DRAIN



## Absolute Maximum Ratings

(@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage	500	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Continuous Drain Current ( $T_A=25^\circ\text{C}$ )	3	A
$I_D$	Continuous Drain Current ( $T_A=100^\circ\text{C}$ )	1.54	A
$I_{DM}$	Pulsed Drain Current <sup>(1)</sup>	8	A
$E_{AS}$	Single Pulsed Avalanche Energy <sup>(2)</sup>	35	mJ
$P_D$	Power Dissipation	29	W
$R_{\theta JC}$	Thermal Resistance from Junction to Case	3.5	$^\circ\text{C}/\text{W}$
$T_J$	Junction Temperature	150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature	-55~+150	$^\circ\text{C}$



## Electrical Characteristics

( $T_A = 25^\circ\text{C}$  unless otherwise specified)

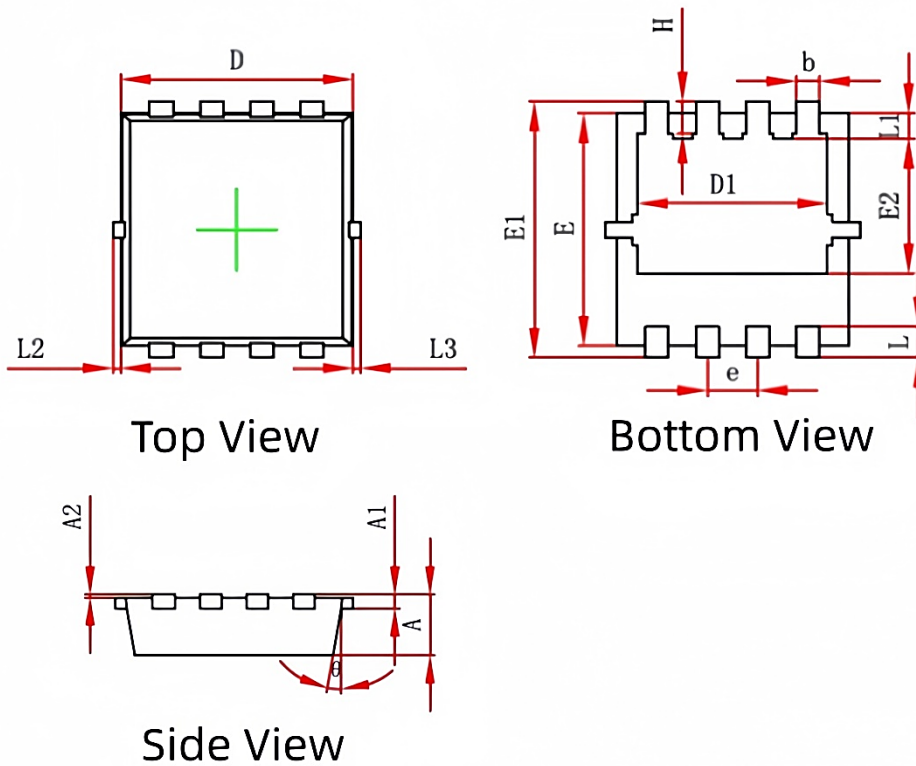
Symbol	Parameter	TestCondition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS}=0V, I_D=250\mu A$	500	-	-	V
$I_{DSS}$	Zero gate voltage drain current	$V_{DS}=500V, V_{GS}=0V$	-	-	1	$\mu A$
$I_{GSS}$	Gate-body leakage current	$V_{GS}=\pm 30V, V_{DS}=0V$	-	-	$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage <sup>(3)</sup>	$V_{DS}=V_{GS}, I_D=250\mu A$	2	3.6	4	V
$R_{DS(on)}$	Drain-source on-resistance <sup>(3)</sup>	$V_{GS}=10V, I_D=1.5A$	-	2.6	3.5	$\Omega$
$g_{FS}$	Forward transconductance <sup>(3)</sup>	$V_{DS}=10V, I_D=1.5A$	0.5	-	-	S
<b>Dynamic characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=25V,$ $V_{GS}=0V,$ $f=1MHz$	-	331	-	pF
$C_{oss}$	Output Capacitance		-	24	-	
$C_{rss}$	Reverse Transfer Capacitance		-	3	-	
<b>Switching characteristics</b>						
$t_{d(off)}$	Turn-off delay time	$V_{DD}=300V, L_D=3A,$ $V_{GS}=10V,$ $R_G=25\Omega$	-	13	-	ns
$Q_g$	Total Gate Charge	$V_{DS}=480V,$ $I_D=1A,$ $V_{GS}=10V$	-	4.8	-	nC
$Q_{gs}$	Gate-Source Charge		-	0.7	-	
$Q_{gd}$	Gate-Drain Charge		-	2.7	-	
<b>Source-Drain Diode characteristics</b>						
$V_{DS}$	Diode Forward voltage <sup>(3)</sup>	$V_{GS}=0V, I_S=3A$	-	-	1.4	V
$I_S$	Diode Forward current <sup>(4)</sup>		-	-	3	A
$t_{rr}$	Body Diode Reverse Recovery Time	$T_J=25^\circ\text{C}, I_F=3A,$ $di/dt=100A/\mu s$	-	190	-	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$T_J=25^\circ\text{C}, I_F=3A,$ $di/dt=100A/\mu s$	-	0.53	-	$\mu c$

Notes:

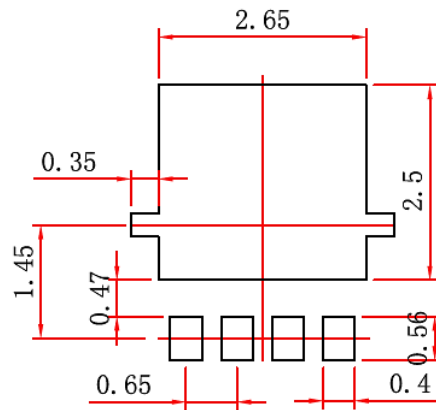
1. Repetitive Rating:pulse width limited by maximum junction temperature
2.  $E_{AS}$  Condition: $T_J=25^\circ\text{C}, V_{DD}=50V, R_G=2.0\Omega, L=10mH$
3. Pulse Test:pulse width $\leq 300\mu s$ , duty cycle  $\leq 2\%$
4. Surface Mounted on FR4 Board, $t \leq 10$  sec



## Package Mechanical Data(PDFN 3x3-8)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.650	0.850	0.026	0.033
A1	0.152 REF.		0.006 REF.	
A2	0~0.05		0~0.002	
D	2.900	3.100	0.114	0.122
D1	2.300	2.600	0.091	0.102
E	2.900	3.100	0.114	0.122
E1	3.150	3.450	0.124	0.136
E2	1.535	1.935	0.060	0.076
b	0.200	0.400	0.008	0.016
e	0.550	0.750	0.022	0.030
L	0.300	0.500	0.012	0.020
L1	0.180	0.480	0.007	0.019
L2	0~0.100		0~0.004	
L3	0~0.100		0~0.004	
H	0.315	0.515	0.012	0.020
$\theta$	9°	13°	9°	13°



Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.05\text{mm}$ .
3. The pad layout is for reference purposes only.

### Ordering information

Order Code	Package	$V_{DS}(V)$	$I_D(A)$	$R_{DS(ON)}(m\Omega)$	
QNM3N50NA	PDFN 3x3-8	500	3	$V_{GS}=10V$	< 3.5